


<b>Search Notes</b>  	<b>Application/Control No.</b>  10535086	<b>Applicant(s)/Patent Under Reexamination</b>  ISHIKAWA ET AL.
	<b>Examiner</b>  Mitchell, Laura M	<b>Art Unit</b>  1636

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST USPGPub, USOCR, EPO,JPO, USPat, DERWENT (Search Notes attached)	8/26/2007	LMM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner